

## U74AUC125

Advance

CMOS IC

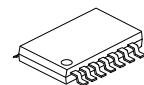
QUADRUPLE BUS BUFFER  
GATE WITH 3-STATE OUTPUTS

## ■ DESCRIPTION

The **U74AUC125** device is designed for 0.8V to 2.7V  $V_{CC}$  operation, but is designed specifically for 1.6V to 1.95V  $V_{CC}$  operation.

This device contains four independent line drivers with 3-state outputs. Each output is disabled when the associated output-enable input is high. To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

This device is fully specified for partial-power-down applications using  $I_{OFF}$ . The  $I_{OFF}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.



TSSOP-14

## ■ FEATURES

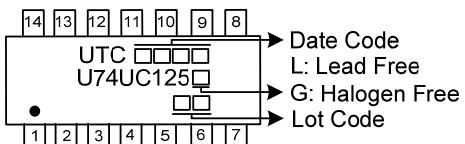
- \* Optimized for 1.8-V Operation and Is 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- \*  $I_{OFF}$  supports live insertion, partial-power-down mode, back-drive protection
- \* Inputs accept voltages up to 2.7V
- \* Max  $t_{pd}$  of 2.1ns at 1.8V
- \* Low static power consumption;  $I_{CC} = \pm 10\mu A$  (Max.)
- \*  $\pm 8mA$  Output Drive at 1.8V

## ■ ORDERING INFORMATION

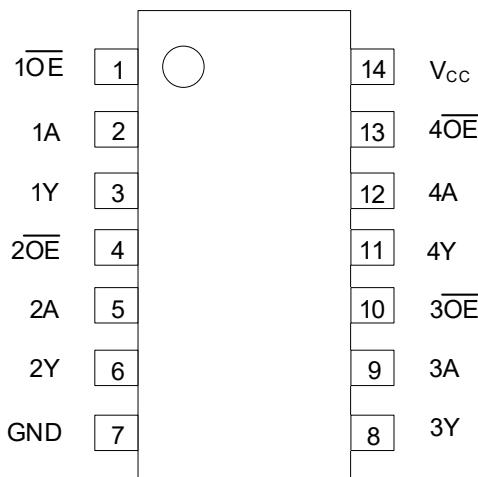
Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74UC125L-P14-R	U74UC125G-P14-R	TSSOP-14	Tape Reel

U74UC125G-P14-R 	(1)Packing Type (2)Package Type (3)Green Package (1) R: Tape Reel (2) P14: TSSOP-14 (3) G: Halogen Free and Lead Free, L: Lead Free
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## ■ MARKING



■ PIN CONFIGURATION

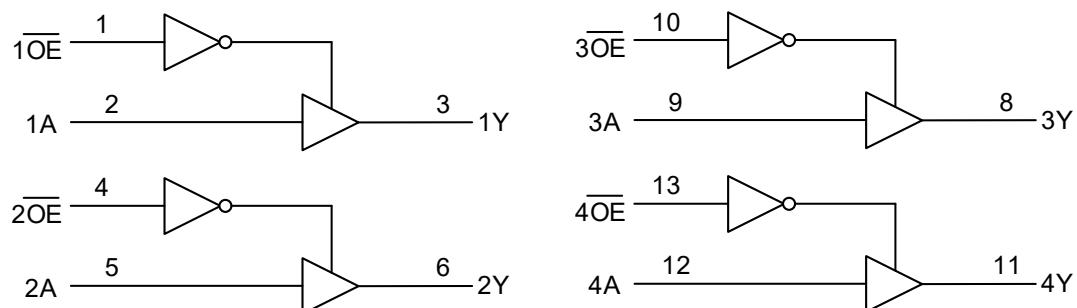


■ FUNCTION TABLE (each gate)

INPUT( $\overline{OE}$ )	INPUT(B)	OUTPUT(Y)
L	H	H
L	L	L
H	X	Z

Note: H: HIGH Voltage Level L: LOW Voltage Level Z: High Impedance X: Don' Care

■ LOGIC DIAGRAM (positive logic)



■ ABSOLUTE MAXIMUM RATING ( $T_A=25^\circ\text{C}$ , unless otherwise specified)

PARAMETER	SYMBOL	CONDITIONS	RATINGS	UNIT
Supply Voltage	$V_{CC}$		-0.5 ~ +3.6	V
Input Voltage	$V_{IN}$		-0.5 ~ +3.6	V
Output Voltage	$V_{OUT}$	Output in the high or low state	-0.5 ~ $V_{CC}$ +0.5	V
		Output in the power-off state	-0.5 ~ +3.6	V
Continuous $V_{CC}$ or GND Current	$I_{CC}$		$\pm 100$	mA
Continuous Output Current	$I_{OUT}$		$\pm 50$	mA
Input Clamp Current	$I_{IK}$	$V_{IN} < 0V$	-50	mA
Output Clamp Current	$I_{OK}$	$V_{OUT} < 0V$	-50	mA
Storage Temperature Range	$T_{STG}$		-65 ~ +150	$^\circ\text{C}$

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	$V_{CC}$	Operating	0.8		2.7	V
Input Voltage	$V_{IN}$		0		3.6	V
Output Voltage	$V_{OUT}$	Active state	0		$V_{CC}$	V
		3-state	0		3.6	V
Input Transition Rise or Fall Rate	$\Delta t/\Delta v$				20	ns/V
Operating Temperature	$T_A$		-40		+125	$^\circ\text{C}$

■ ELECTRICAL CHARACTERISTICS ( $T_A=25^\circ\text{C}$ , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-Level Input Voltage	$V_{IH}$	$V_{CC}=0.8V$	$V_{CC}$			V
		$V_{CC}=1.1 \sim 1.95V$	$0.65 \times V_{CC}$			V
		$V_{CC}=2.3 \sim 2.7V$	1.7			V
Low-Level Input Voltage	$V_{IL}$	$V_{CC}=0.8V$			0	V
		$V_{CC}=1.1 \sim 1.95V$			$0.35 \times V_{CC}$	V
		$V_{CC}=2.3 \sim 2.7V$			0.7	V
High-Level Output Voltage	$V_{OH}$	$V_{CC}=0.8 \sim 2.7V, I_{OH}=-100\mu\text{A}$	$V_{CC}-0.1$			V
		$V_{CC}=0.8V, I_{OH}=-0.7\text{mA}$		0.46		V
		$V_{CC}=1.1V, I_{OH}=-3\text{mA}$	0.77			V
		$V_{CC}=1.4V, I_{OH}=-5\text{mA}$	1			V
		$V_{CC}=1.65V, I_{OH}=-8\text{mA}$	1.2			V
		$V_{CC}=2.3V, I_{OH}=-9\text{mA}$	1.8			V
Low-Level Output Voltage	$V_{OL}$	$V_{CC}=0.8 \sim 2.7V, I_{OL}=100\mu\text{A}$			0.2	V
		$V_{CC}=0.8V, I_{OL}=0.7\text{mA}$		0.25		V
		$V_{CC}=1.1V, I_{OL}=3\text{mA}$			0.3	V
		$V_{CC}=1.4V, I_{OL}=5\text{mA}$			0.4	V
		$V_{CC}=1.65V, I_{OL}=8\text{mA}$			0.45	V
		$V_{CC}=2.3V, I_{OL}=9\text{mA}$			0.6	V
Input Leakage Current	$I_{I(LEAK)}$	$V_{CC}=0 \sim 2.7V, V_{IN} = V_{CC}$ or GND			$\pm 5$	$\mu\text{A}$
Power Off Leakage Current	$I_{OFF}$	$V_{CC}=0V, V_{IN}$ or $V_{OUT}=2.7V$			$\pm 10$	$\mu\text{A}$
Quiescent Supply Current	$I_{CC}$	$V_{CC}=0.8 \sim 2.7V, V_{IN} = V_{CC}$ or GND, $I_{OUT}=0$			10	$\mu\text{A}$

Note:  $I_{OL}$  and  $I_{OH}$  are tested one output at a time.

■ SWITCHING CHARACTERISTICS

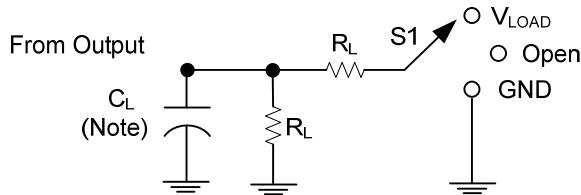
( $T_A=25^\circ\text{C}$ , Input:  $t_R=t_F=20\text{ns}$ ,  $C_L=15\text{pF}$ ,  $R_L=2\text{k}\Omega$ , unless otherwise specified )

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from Input(A) to Output(Y)	$t_{PD}$	$V_{CC}=0.8V \pm 0.15V$		5.8		ns
		$V_{CC}=2.5V \pm 0.2V$	0.5		2.1	ns
Enable Delay Time, Input ( $\overline{OE}$ ) to Output(Y)	$t_{EN}$	$V_{CC}=0.8V \pm 0.15V$		7.5		ns
		$V_{CC}=2.5V \pm 0.2V$	0.6		2.3	ns
Disable Delay Time, Input ( $\overline{OE}$ ) to Output(Y)	$t_{DIS}$	$V_{CC}=0.8V \pm 0.15V$		6.4		ns
		$V_{CC}=2.5V \pm 0.2V$	0.8		2.3	ns

■ OPERATING CHARACTERISTICS ( $T_A=25^\circ\text{C}$ , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input Capacitance	$C_{IN}$	$V_{CC}=2.5V$ , $V_{IN}=V_{CC}$ or GND		2.5		pF
Output Capacitance	$C_{OUT}$	$V_{CC}=2.5V$ , $V_{OUT}=V_{CC}$ or GND		5		pF
Power Dissipation Capacitance	$C_{PD}$	Outputs enabled, $f=10\text{MHz}$	$V_{CC}=0.8V$ ,	15		pF
			$V_{CC}=1.2V$	15		pF
			$V_{CC}=1.5V$	15		pF
			$V_{CC}=1.8V$	16		pF
			$V_{CC}=2.5V$	17		pF
		Outputs disabled, $f=10\text{MHz}$	$V_{CC}=0.8V$ ,	2		pF
			$V_{CC}=1.2V$	2		pF
			$V_{CC}=1.5V$	2		pF
			$V_{CC}=1.8V$	3		pF
			$V_{CC}=2.5V$	4		pF

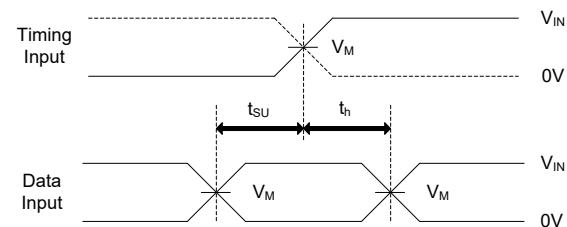
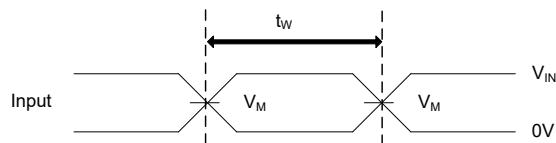
■ TEST CIRCUIT AND WAVEFORMS



TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	$V_{LOAD}$
$t_{PHZ}/t_{PZH}$	GND

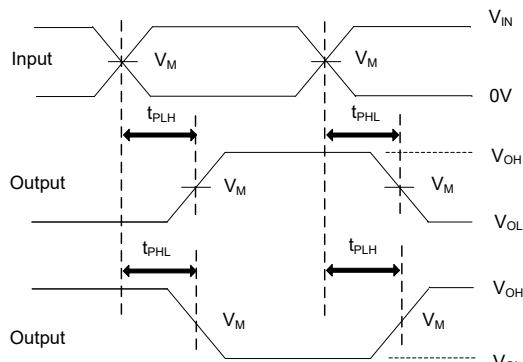
Note:  $C_L$  includes probe and jig capacitance.

$V_{CC}$	$C_L$	$R_L$	$V_\Delta$
.8V	15pF	2KΩ	0.1V
$1.2V \pm 0.1V$	15pF	2KΩ	0.1V
$1.5V \pm 0.1V$	15pF	2KΩ	0.1V
$1.8V \pm 0.15V$	15pF	2KΩ	0.15V
$2.5V \pm 0.2V$	15pF	2KΩ	0.15V
$1.8V \pm 0.15V$	30pF	1KΩ	0.15V
$2.5V \pm 0.2V$	30pF	500Ω	0.15V

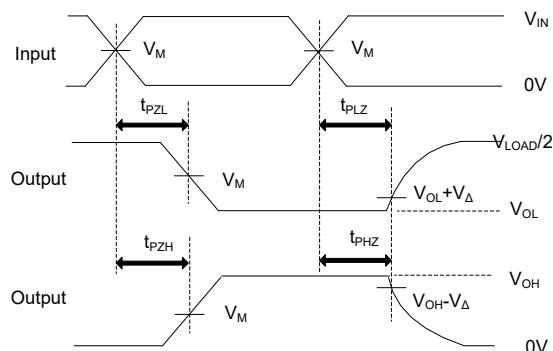


PULSE WIDTH

SETUP TIME AND HOLD TIME



PROPAGATION DELAY TIMES



ENABLE AND DISABLE TIMES

Notes: 1.  $C_L$  includes probe and jig capacitance.

2. All input pulses are supplied by generators having the following characteristics: PRR  $\leq 10\text{MHz}$ ,  $Z_O = 50\Omega$ .

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